

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/630,848	IWASAKI ET AL.	
	Examiner	Art Unit	
	Ryan Gleitz	2852	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,749,022	05-1998	Kikui et al.	399/50
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 05181350 A	07-1993	Japan	ENDO, KENJI	G03G 15/02
	O	JP 08123152 A	05-1996	Japan	MAEHASHI et al.	G03G 15/02
	P	JP 10198129 A	07-1998	Japan	FUJINO, TAKESHI	G03G 15/02
	Q	JP 2001154462 A	06-2001	Japan	ARATAIRAI et al.	G03G 15/02
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.